# **30V P-CHANNEL ENHANCEMENT MODE MOSFET**

**SUMMARY** 

 $V_{(BR)DSS}$  = -30V:  $R_{DS(on)}$  = 0.045 $\Omega$ :  $I_D$  = -7.5A

## **DESCRIPTION**

This new generation of trench MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.



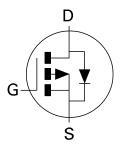
**SOT223** 

## **FEATURES**

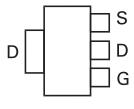
- Low on-resistance
- · Fast switching speed
- Low threshold
- Low gate drive
- SOT223 package

# **APPLICATIONS**

- DC-DC converters
- Power management functions
- · Relay and soleniod driving
- Motor control



## **PINOUT**



Top View

### **ORDERING INFORMATION**

DEVICE	REEL SIZE	TAPE WIDTH	QUANTITY PER REEL	
ZXMP3A16GTA	7″	12mm	1000 units	
ZXMP3A16GTC	13"	12mm	4000 units	

## **DEVICE MARKING**

ZXMP 3A16



# **ABSOLUTE MAXIMUM RATING**

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V <sub>DSS</sub>	-30	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current ( $V_{GS}$ = -10V; $T_A$ =25°C)(b) ( $V_{GS}$ = -10V; $T_A$ =70°C)(b) ( $V_{GS}$ = -10V; $T_A$ =25°C)(a)	I <sub>D</sub>	-7.5 -6.0 -5.4	А
Pulsed Drain Current (c)	I <sub>DM</sub>	-24.9	А
Continuous Source Current (Body Diode) (b)	Is	-3.2	А
Pulsed Source Current (Body Diode)(c)	I <sub>SM</sub>	-24.9	А
Power Dissipation at T <sub>A</sub> =25°C (a) Linear Derating Factor	P <sub>D</sub>	2.0 16	W mW/°C
Power Dissipation at T <sub>A</sub> =25°C (b) Linear Derating Factor	P <sub>D</sub>	3.9 31	W mW/°C
Operating and Storage Temperature Range	T <sub>j</sub> :T <sub>stg</sub>	-55 to +150	°C

## THERMAL RESISTANCE

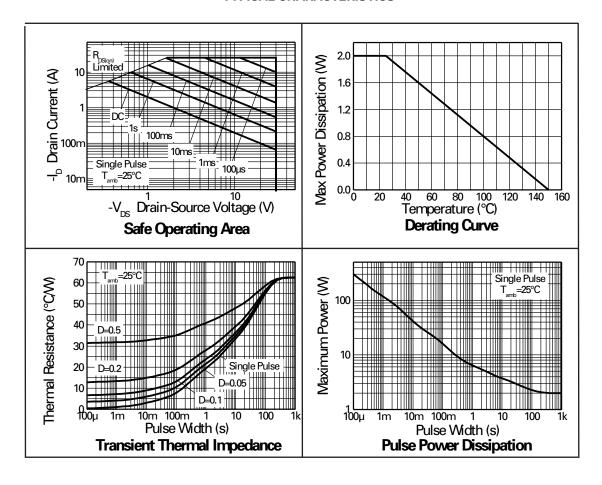
PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)	$R_{\theta JA}$	62.5	°C/W
Junction to Ambient (b)	$R_{\theta JA}$	32.2	°C/W

## NOTES:

- (a) For a device surface mounted on  $25 \text{mm} \times 25 \text{mm}$  FR4 PCB with high coverage of single sided 1oz copper, in still air conditions
- (b) For a device surface mounted on FR4 PCB measured at t≤10 secs.
- (c) Repetitive rating 25mm x 25mm FR4 PCB, D=0.05 pulse width limited by maximum junction temperature.



# **TYPICAL CHARACTERISTICS**





# ELECTRICAL CHARACTERISTICS (at $T_A = 25^{\circ}C$ unless otherwise stated).

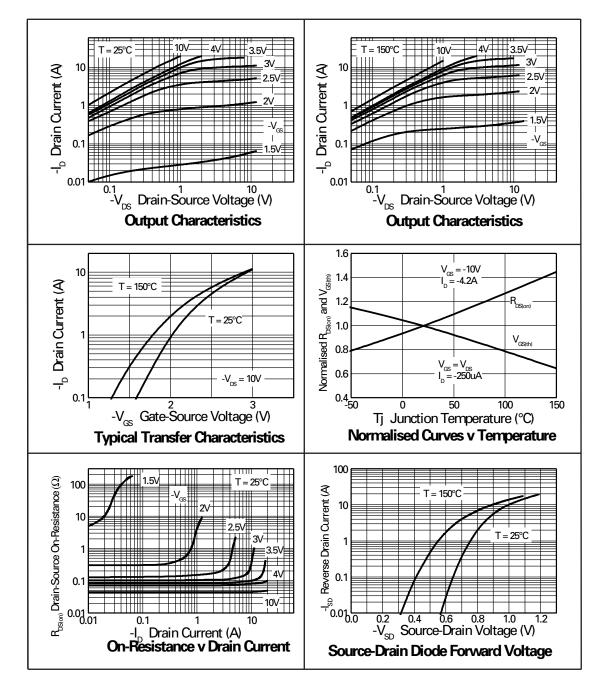
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.	
STATIC				-			
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	-30			V	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>			-1	μΑ	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V	
Gate-Body Leakage	I <sub>GSS</sub>			100	nA	$V_{GS}=\pm 20V$ , $V_{DS}=0V$	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	-1.0			V	I <sub>D</sub> =-250μA, V <sub>DS</sub> = V <sub>GS</sub>	
Static Drain-Source On-State Resistance (1)	R <sub>DS(on)</sub>			0.045 0.070	Ω	V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.2A V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3.4A	
Forward Transconductance (1)(3)	g <sub>fs</sub>		9.2		s	V <sub>DS</sub> =-15V,I <sub>D</sub> =-4.2A	
DYNAMIC (3)							
Input Capacitance	C <sub>iss</sub>		1022		pF	4577.77	
Output Capacitance	C <sub>oss</sub>		267		pF	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f=1MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>		229		pF		
SWITCHING(2) (3)		•					
Turn-On Delay Time	t <sub>d(on)</sub>		3.8		ns		
Rise Time	t <sub>r</sub>		6.5		ns	V <sub>DD</sub> =-15V, I <sub>D</sub> =-1A	
Turn-Off Delay Time	t <sub>d(off)</sub>		37.1		ns	$R_G=6.0\Omega$ , $V_{GS}=-10V$	
Fall Time	t <sub>f</sub>		21.4		ns		
Gate Charge	$Q_g$		17.2		nC	V <sub>DS</sub> =-15V,V <sub>GS</sub> =-5V, I <sub>D</sub> =-4.2A	
Total Gate Charge	Qg		29.6		nC		
Gate-Source Charge	Q <sub>gs</sub>		2.8		nC	V <sub>DS</sub> =-15V,V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.2A	
Gate-Drain Charge	Q <sub>gd</sub>		8.6		nC		
SOURCE-DRAIN DIODE		•				•	
Diode Forward Voltage (1)	V <sub>SD</sub>		-0.85	-0.95	V	T <sub>J</sub> =25°C, I <sub>S</sub> =-3.6A, V <sub>GS</sub> =0V	
Reverse Recovery Time (3)	t <sub>rr</sub>		21.7		ns	T <sub>J</sub> =25°C, I <sub>F</sub> =-2A,	
Reverse Recovery Charge (3)	Q <sub>rr</sub>		16.1		nC	di/dt= 100A/μs	

## NOTES

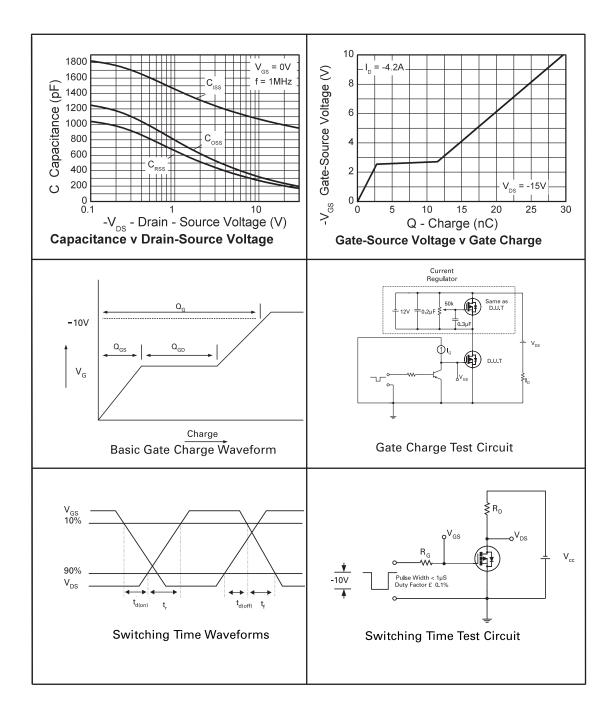
- (1) Measured under pulsed conditions. Width  ${\leq}300\mu$  s. Duty cycle  ${\leq}~2\%$  .
- (2) Switching characteristics are independent of operating junction temperature.
- (3) For design aid only, not subject to production testing.



## **TYPICAL CHARACTERISTICS**









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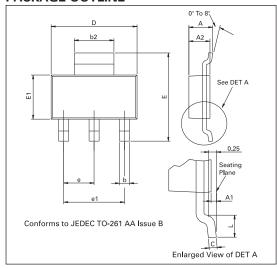
- "Preview"Future device intended for production at some point. Samples may be available
- "Active"Product status recommended for new designs
- "Last time buy (LTB)"Device will be discontinued and last time buy period and delivery is in effect
- "Not recommended for new designs"Device is still in production to support existing designs and production
- "Obsolete"Production has been discontinued

### Datasheet status key:

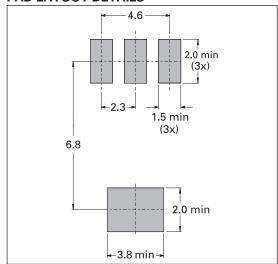
- "Draft version"This term denotes a very early datasheet version and contains highly provisional
- information, which may change in any manner without notice.
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# **PACKAGE OUTLINE**



# **PAD LAYOUT DETAILS**



## **PACKAGE DIMENSIONS**

	Millin	neters	Inc	hes		Millin	neters	Inc	hes
DIM	IVIIIIIII	ieteis	IIIC	1162	DIM	IVIIIIIII	ieters	IIIC	1162
Dilivi	Min	Max	Min	Max	D.IIVI	Min	Max	Min	Max
Α	-	1.80	-	0.071	е	2.30	BSC	0.090	5 BSC
A1	0.02	0.10	0.0008	0.004	e1	4.60 BSC		0.181 BSC	
b	0.66	0.84	0.026	0.033	Е	6.70	7.30	0.264	0.287
b2	2.90	3.10	0.114	0.122	E1	3.30	3.70	0.130	0.146
С	0.23	0.33	0.009	0.013	L	0.90	-	0.355	-
D	6.30	6.70	0.248	0.264	-	-	-	-	-

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Europe	

Zetex GmbH Kustermann-Park Balanstraße 59 D-81541 München Germany Telefon: (49) 89 45 49 49 0 Fax: (49) 89 45 49 49 9 europe.sales@zetex.com

### America

Zetex Inc 700 Veterans Memorial Hwy Hauppauge, NY 11788 USA

Telephone: (1) 631 360 2222 Fax: (1) 631 360 8222 usa.sales@zetex.com

### Asia Pacific

Zetex (Asia) Ltd 3701-04 Metroplaza Tower 1 Hing Fong Road, Kwai Fong Hong Kong

Telephone: (852) 26100 611 Fax: (852) 24250 494 asia.sales@zetex.com

## Corporate Headquarters

Zetex Semiconductors plc Zetex Technology Park Chadderton, Oldham, OL9 9LL United Kingdom

Telephone (44) 161 622 4444 Fax: (44) 161 622 4446 hq@zetex.com

